SHARP

PC457S0NIP0F Series

High Speed 1Mb/s, High CMR Mini-flat Package *OPIC Photocoupler



Description

PC457S0NIP0F Series contains a LED optically coupled to an OPIC.

It is packaged in a 8 pin mini-flat.

Input-output isolation voltage(rms) is 3.75 kV.

High speed response (TYP. 1Mb/s) and CMR is MIN. $15 kV/\mu s.$

Features

- 1.8 pin Mini-flat package
- 2. Double transfer mold package (Ideal for Flow Soldering)
- 3. High noise immunity due to high instantaneous common mode rejection voltage (CM_H : MIN. 15kV/ μ s, CM_L : MIN. –15kV/ μ s)
- 4. High speed response (t_{PHL} : TYP. 0.2μs, t_{PLH} : TYP. 0.4μs)
- 5. Isolation voltage between input and output ($V_{iso(rms)}$: 3.75kV)
- 6. Lead-free and RoHS driective compliant

■ Agency approvals/Compliance

- 1. Recognized by UL1577 (Double protection isolation), file No. E64380 (as model No. **PC457S**)
- 2. Approved by VDE, DIN EN60747-5-2^(*) (as an option), file No. 40009162 (as model No. **PC457S**)
- 3. Package resin : UL flammability grade (94V-0))

(*) DIN EN60747-5-2 : successor standard of DIN VDE0884.

Applications

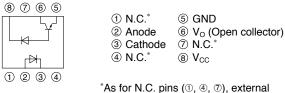
- 1. Programmable controller
- 2. Inverter

* "OPIC"(Optical IC) is a trademark of the SHARP Corporation. An OPIC consists of a light-detecting element and a signal-processing circuit integrated onto a single chip.

Notice The content of data sheet is subject to change without prior notice. In the absence of confirmation by device specification sheets, SHARP takes no responsibility for any defects that may occur in equipment using any SHARP devices shown in catalogs, data books, etc. Contact SHARP in order to obtain the latest device specification sheets before using any SHARP device.



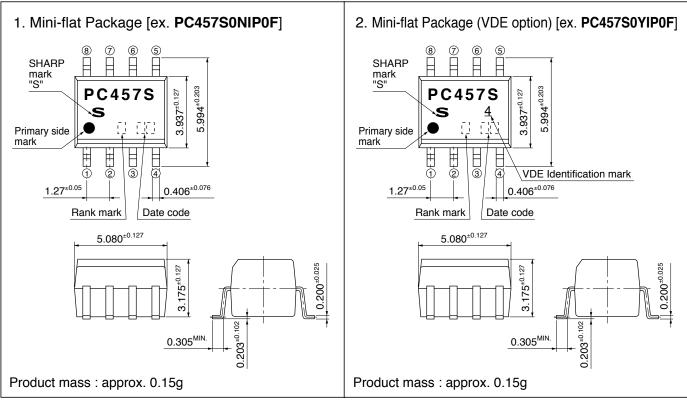
Internal Connection Diagram



*As for N.C. pins (①, ④, ⑦), external connection is not allowed.

■ Outline Dimensions

(Unit : mm)



Plating material : Pd (Au flush)



Date code (2 digit)

	1st o	digit		2nd digit		
	Year of p	roduction		Month of production		
A.D.	Mark	A.D.	Mark	Month	Mark	
1990	А	2002	Р	January	1	
1991	В	2003	R	February	2	
1992	С	2004	S	March	3	
1993	D	2005	Т	April	4	
1994	Е	2006	U	May	5	
1995	F	2007	V	June	6	
1996	Н	2008	W	July	7	
1997	J	2009	Х	August	8	
1998	K	2010	А	September	9	
1999	L	2011	В	October	0	
2000	М	2012	С	November	N	
2001	N	:	:	December	D	

repeats in a 20 year cycle

Country of origin Japan

Rank mark

With or without.

■ Absolute Maximum Ratings

	Parameter	Symbol	Rating	Unit		
	*1 Forward current	$I_{\rm F}$	25	mA		
Input	Reverse input voltage	V _R	5	V		
	*2 Input power dissipation	PI	45	mW		
	Supply voltage	V _{CC}	-0.5 to +30	V		
Output	Output voltage	Vo	-0.5 to +20	V		
Output	Output current	Io	8	mA		
	*3 Output power dissipation	Po	100	mW		
*4 Isolation voltage		V _{iso(rms)}	3.75	kV		
Operating temperature		T _{opr}	-55 to +100	°C		
Storage temperature		T _{stg}	-55 to +125	°C		
*5 Soldering temperature		T _{sol}	270	°C		

*1 When ambient temperature goes above 85°C, the forward current goes down at 0.6mA/°C. Refer to Fig.3

*2 When ambient temperature goes above 85°C, the forward current goes down at 1.1mW/°C. Refer to Fig.4

*3 When ambient temperature goes above 85°C, the forward current goes down at 2.5mW/°C. Refer to Fig.4

*4 AC for 1minute, 40 to 60%RH, f=60Hz

*5 For 10s

Electro-optical Characteristics

 $(T_a=25^{\circ}C)$

	Parameter	Symbol	Cond	lition	MIN.	TYP.	MAX.	Unit
	Input forward voltage		I 16m A		_	1.5	1.7	X 7
Input		*7V _F	I _F =16mA		-	_	1.8	V
Inp	Reverse input voltage	I _R	V _R =	=5V	-	-	10	μΑ
	Input capacitance	Ct	V _F =0, f	=1MHz	-	60	-	pF
		I _{OH} (1)	$I_{F}=0, V_{CC}=5.$	5V, V ₀ =5.5V	-	3	500	nA
	High level output current	I _{OH} (2)	$I_{E}=0, V_{CC}=1$	5V V 15V	_	0.01	1	
t		*7I _{OH} (3)	$I_F=0, V_{CC}=1$	$5 v, v_0 = 15 v$	-	_	50	μA
*6 Output	High level supply current	I _{CCH} (1)	$I_{F}=0, V_{CC}=15$	V V ODEN	-	0.02	1	μΑ
°0	ringin level supply current	*7I _{CCH} (2)	$I_{\rm F}=0, V_{\rm CC}=1.5$	$\mathbf{v}, \mathbf{v}_0 = \mathbf{Or} \mathbf{E} \mathbf{N}$	-	_	2	
*	Low level supply current	I _{CCL}	$I_F=16mA, V_{CC}=$	15V, V _O =OPEN	-	50	200	μA
	Low level output voltage	V _{OL} (1)	I _F =16mA, V _{CC} =4.5V, I _O =3mA		-	-	0.4	v
	Low level output voltage	$^{*7}V_{OL}(2)$	$I_F=16mA$, $V_{CC}=4.5V$, $I_O=2.4mA$		-	-	0.5	
	Current transfer ratio	CTR(1)	$I_{F}=16mA$, $V_{CC}=4.5V$, $V_{O}=0.4V$		19	_	50	%
		*7CTR(2)	$I_F=16mA$, $V_{CC}=4.5V$, $V_O=0.5V$		15	_	-	70
cs	^{*8} "High→Low" propagation delay time	$t_{PHL}(1)$	$I_{F}=16mA$, $V_{CC}=5V$, $R_{L}=1.9k\Omega$		-	0.2	0.8	- μs
risti	Tign-Low propagation delay time	*7t _{PHL} (2)			-	_	1	
lcte	^{*8} "Low→High" propagation delay time	$t_{PLH}(1)$			_	0.3	0.8	
nara	Low→right propagation delay time	*7t _{PLH} (2)			-	_	1	
*6 Transfer characteristics	*9 Instantaneous common mode rejection	CM _H	I _F =0,	$R_L=1.9k\Omega$,	15	30		kV/μs
nsfe	voltage (High level output)	CIVIH	$V_0(MIN)=2V$ $V_{CC}=5V$,	V _{CC} =5V,	15	50	-	κν/μs
Tra	^{*9} Instantaneous common mode rejection	CML	$I_F=16mA$,	$V_{CM} = 1 k V_{(P-P)},$	-15	-30	1-17/-	kV/µs
9*	voltage (Low level output)		$V_0(MAX)=0.8V$	C _L =15pF			-	κν/μδ
	Isolation resistance	R _{ISO}	DC500V, 40) to 60%RH	5×10 ¹⁰	10 ¹¹	-	Ω
	Floating capacitance	Cf	V=0, f=	=1MHz	-	0.6	-	pF

 $(T_a=25^{\circ}C)$

*6 It shall connect a by-pass capacitor of 0.01µF or more between V_{CC} (pin [®]) and GND (pin [®]) near the device, when it measures the transfer characteristics and the output side characteristics

*7 T_a=0 to 70°C

*8 Propagation delay time : Refer to Fig.1

*9 Instantaneous common mode rejection voltage : Refer to Fig.2



■ Model Line-up

Dealsaga	Taping			
Package	1 500pcs/reel			
DIN EN60747-5-2		Approved		
Model No.	PC457S0NIP0F	PC457S0YIP0F		

Please contact a local SHARP sales representative to inquire about production status.



Fig.1 Test Circuit for Propagation Delay Time

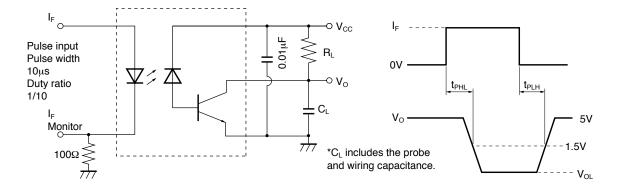
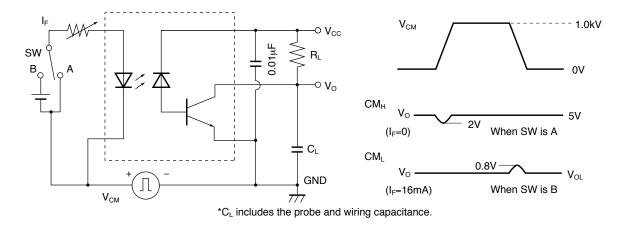


Fig.2 Test Circuit for Instantaneous Common Mode Rejection Voltage



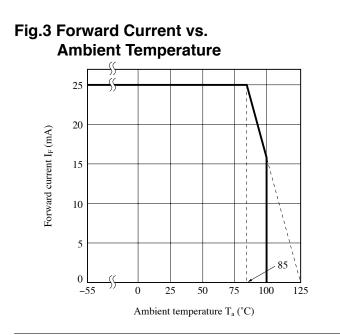


Fig.4 Power Dissipation vs. Ambient Temperature

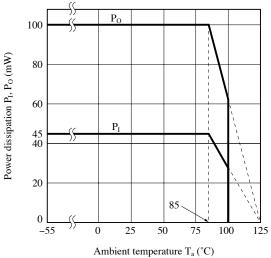




Fig.5 Forward Current vs. Forward Voltage

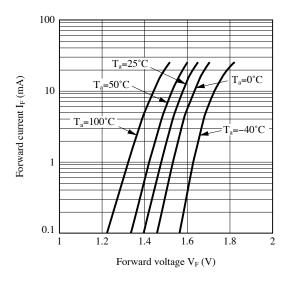
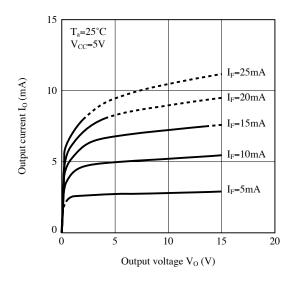


Fig.7 Output Current vs. Output Voltage





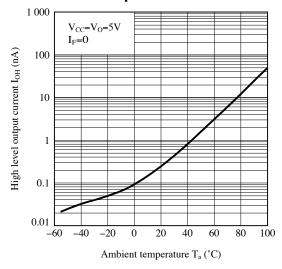


Fig.6 Relative Current Transfer Ratio vs. Forward Current

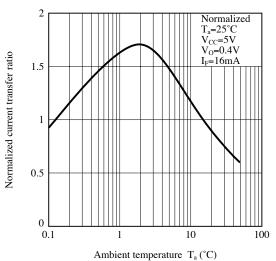


Fig.8 Relative Current Transfer Ratio vs. Ambient Temperature

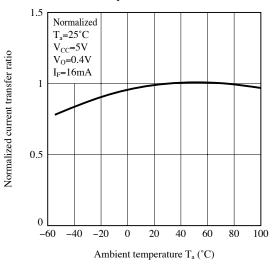


Fig.10 Propagation Delay Time vs. Ambient Temperature

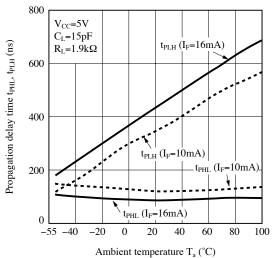
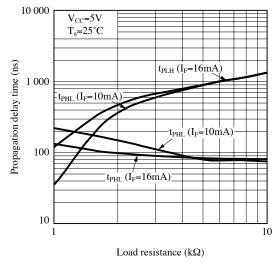




Fig.11 Propagation Delay Time vs. Load Resistance



Remarks : Please be aware that all data in the graph are just for reference and anot for guarantee.

SHARP

Design Considerations

• Recommended operating conditions

Parameter	Symbol	MIN.	TYP.	MAX.	Unit
Input current	I _F	7	-	16	mA
Supply voltage	V _{CC}	_	5	_	V
Operating temperature	T _{opr}	0	_	+85	°C

Notes about static electricity

Transistor of detector side in bipolar configuration may be damaged by static electricity due to its minute design.

When handling these devices, general countermeasure against static electricity should be taken to avoid breakdown of devices or degradation of characteristics.

Design guide

In order to stabilize power supply line, we should certainly recommend to connect a by-pass capacitor of 0.01μ F or more between V_{CC} and GND near the device.

In case that some sudden big noise caused by voltage variation is provided between primary and secondary terminals of photocoupler some current caused by it is floating capacitance may be generated and result in false operation since current may go through LED or current may change.

If the photocoupler may be used under the circumstances where noise will be generated we recommend to use the bypass capacitors at the both ends of LED.

The detector which is used in this device, has parasitic diode between each pins and GND.

There are cases that miss operation or destruction possibly may be occurred if electric potential of any pin becomes below GND level even for instant.

Therefore it shall be recommended to design the circuit that electric potential of any pin does not become below GND level.

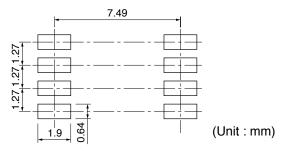
NC terminals (Pin 0, 4 and 7) are not allowed external connection.

This product is not designed against irradiation and incorporates non-coherent LED.

Degradation

In general, the emission of the LED used in photocouplers will degrade over time. In the case of long term operation, please take the general LED degradation (50% degradation over 5 years) into the design consideration.

Recommended foot print (reference)



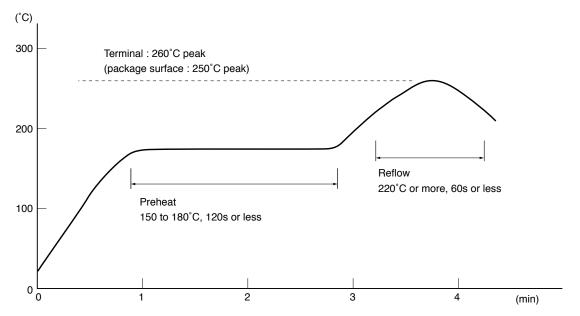


Manufacturing Guidelines

Soldering Method

Reflow Soldering:

Reflow soldering should follow the temperature profile shown below. Soldering should not exceed the curve of temperature profile and time. Please don't solder more than twice.



Flow Soldering :

Due to SHARP's double transfer mold construction submersion in flow solder bath is allowed under the below listed guidelines.

Flow soldering should be completed below 270°C and within 10s. Preheating is within the bounds of 100 to 150°C and 30 to 80s. Please don't solder more than twice.

Hand soldering

Hand soldering should be completed within 3s when the point of solder iron is below 400°C. Please don't solder more than twice.

Other notice

Please test the soldering method in actual condition and make sure the soldering works fine, since the impact on the junction between the device and PCB varies depending on the tooling and soldering conditions.



• Cleaning instructions

Solvent cleaning :

Solvent temperature should be 45°C or below. Immersion time should be 3 minutes or less.

Ultrasonic cleaning :

The impact on the device varies depending on the size of the cleaning bath, ultrasonic output, cleaning time, size of PCB and mounting method of the device.

Therefore, please make sure the device withstands the ultrasonic cleaning in actual conditions in advance of mass production.

Recommended solvent materials :

Ethyl alcohol, Methyl alcohol and Isopropyl alcohol.

In case the other type of solvent materials are intended to be used, please make sure they work fine in actual using conditions since some materials may erode the packaging resin.

• Presence of ODC

This product shall not contain the following materials. And they are not used in the production process for this product. Regulation substances : CFCs, Halon, Carbon tetrachloride, 1.1.1-Trichloroethane (Methylchloroform)

Specific brominated flame retardants such as the PBB and PBDE are not used in this product at all.

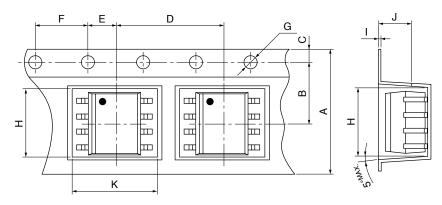
This product shall not contain the following materials banned in the RoHS Directive (2002/95/EC).
•Lead, Mercury, Cadmium, Hexavalent chromium, Polybrominated biphenyls (PBB), Polybrominated diphenyl ethers (PBDE).



• Tape and Reel package SMT Gullwing

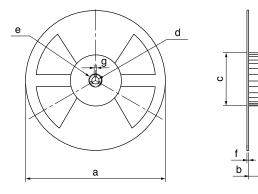
Package materials Carrier tape : PS Cover tape : PET (three layer system) Reel : PS

Carrier tape structure and Dimensions



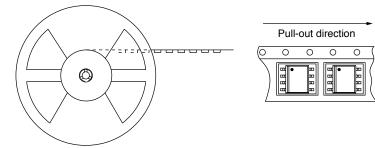
Dimensions List (Unit : m						
А	В	С	D	Е	F	G
12.0 ^{±0.3}	5.50 ^{±0.05}	$1.75^{\pm 0.10}$	$8.0^{\pm0.1}$	$2.00^{\pm 0.05}$	$4.0^{\pm 0.1}$	φ1.55 ^{±0.05}
Н	Ι	J	K			
5.4 ^{±0.1}	0.30 ^{±0.05}	$3.7^{\pm 0.1}$	6.3 ^{±0.1}			

Reel structure and Dimensions



Dim	ensio	ns List	(Unit : mm)		
	a	b	с	d	
φ.	φ330 13.5 ^{±1.5}		φ100 ^{±1}	\$\$13.0 ^{±0.2}	
	e	f	g		
φ21	$.0^{\pm 0.8}$	2.0 ^{TYP.}	$2.0^{\pm 0.5}$		

Direction of product insertion



[Packing : 1 500pcs/reel]

SHARP

Important Notices

• The circuit application examples in this publication are provided to explain representative applications of SHARP devices and are not intended to guarantee any circuit design or license any intellectual property rights. SHARP takes no responsibility for any problems related to any intellectual property right of a third party resulting from the use of SHARP's devices.

• Contact SHARP in order to obtain the latest device specification sheets before using any SHARP device. SHARP reserves the right to make changes in the specifications, characteristics, data, materials, structure, and other contents described herein at any time without notice in order to improve design or reliability. Manufacturing locations are also subject to change without notice.

 \cdot Observe the following points when using any devices in this publication. SHARP takes no responsibility for damage caused by improper use of the devices which does not meet the conditions and absolute maximum ratings to be used specified in the relevant specification sheet nor meet the following conditions:

(i) The devices in this publication are designed for use in general electronic equipment designs such as:

- --- Personal computers
- --- Office automation equipment
- --- Telecommunication equipment [terminal]
- --- Test and measurement equipment
- --- Industrial control
- --- Audio visual equipment
- --- Consumer electronics

(ii) Measures such as fail-safe function and redundant design should be taken to ensure reliability and safety when SHARP devices are used for or in connection with equipment that requires higher reliability such as:

- --- Transportation control and safety equipment (i.e., aircraft, trains, automobiles, etc.)
- --- Traffic signals
- --- Gas leakage sensor breakers
- --- Alarm equipment
- --- Various safety devices, etc.

(iii) SHARP devices shall not be used for or in connection with equipment that requires an extremely high level of reliability and safety such as:

- --- Space applications
- --- Telecommunication equipment [trunk lines]
- --- Nuclear power control equipment
- --- Medical and other life support equipment (e.g., scuba).

• If the SHARP devices listed in this publication fall within the scope of strategic products described in the Foreign Exchange and Foreign Trade Law of Japan, it is necessary to obtain approval to export such SHARP devices.

• This publication is the proprietary product of SHARP and is copyrighted, with all rights reserved. Under the copyright laws, no part of this publication may be reproduced or transmitted in any form or by any means, electronic or mechanical, for any purpose, in whole or in part, without the express written permission of SHARP. Express written permission is also required before any use of this publication may be made by a third party.

 \cdot Contact and consult with a SHARP representative if there are any questions about the contents of this publication.